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## \*BIBDATASHEET\*

CONFIRMATION NO. 8575

Bib Data Sheet

SERIAL NUMBER 09/869,783	FILING DATE 06/29/2001  RULE	CLASS 250	GROUP ART UNIT 2881	ATTORNEY DOCKET NO. 1743/188
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## APPLICANTS

Kazutoshi Kaji, Hitachi, JAPAN;

Kazuhiro Ueda, Mito, JAPAN;

Koji Kimoto, Tsukuba, JAPAN; Takashi Aoyama, Tokai-mura, JAPAN;

Shunroku Taya, Mito, JAPAN;

Shigeto Isakozawa, Hitachinaka, JAPAN;

## \*\* CONTINUING DATA \*\*\*\*\*

This application is a 371 of PCT/JP99/06418 11/11/1999

## \*\* FOREIGN APPLICATIONS \*\*\*\*\*

JAPAN 11-98 01/04/1999

Foreign Priority claimed

☒ yes ☐ no

35 USC 119 (a-d) conditions met

☒ yes ☐ no☐ Met after Allowance

Verified and Acknowledged

Examiner's Signature

Initials

STATE OR

COUNTRY  
JAPAN

SHEETS

DRAWING  
9

TOTAL

CLAIMS  
10

INDEPENDENT

CLAIMS  
2

## ADDRESS

26646  
 KENYON & KENYON  
 ONE BROADWAY  
 NEW YORK, NY  
 10004

## TITLE

Element mapping device, scanning transmission electron microscope, and element mapping method

☐ All Fees